

STW45NM60

General features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	I _D
STW45NM60	650V	< 0.11Ω	45A

- High dv/dt and avalanche capabilities
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance
- Tight process control and high manufacturing yields

Description

The MDmesh[™] is a new revolutionary Power MOSFET technology that associates the multiple drain process with the Company's PowerMESH[™] horizontal layout. The resulting product has an outstanding low on-resistance, impressively high dv/dt and excellent avalanche characteristics. The adoption of the Company's proprietary strip technique yields overall dynamic performance that is significantly better than that of similar competitor's products.

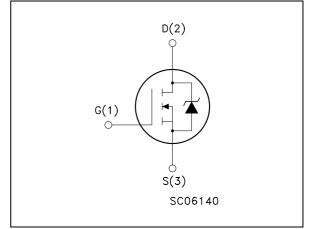
Applications

Switching application

Order codes

TO-247	

Internal schematic diagram



ſ	Part number	Marking	Package	Packaging
	STW45NM60	W45NM60	TO-247	Tube

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate- source voltage	±30	V
۱ _D	Drain current (continuous) at T _C = 25°C	45	Α
I _D	Drain current (continuous) at T _C = 100°C	28	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	180	Α
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	417	W
	Derating factor	3.33	W/°C
dv/dt ⁽²⁾	Peak diode recovery voltage slope	15	V/ns
T _{stg}	Storage temperature	-65 to 150	°C
Тj	Max. operating junction temperature	150	°C

1. Pulse width limited by safe operating area

2. $I_{SD} \le 45A$, di/dt $\le 400A/\mu s$, $V_{DD} \le 80\% V_{(BR)DSS}$

Table 2. Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case	0.3	°C/W
Rthj-amb	Thermal resistance junction-amb	30	°C/W
Τ _Ι	Maximum lead temperature for soldering purpose	300	°C

Table 3. Avalanche characteristics

Symbol	Parameter	Max value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _j max)	15	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 35 \text{ V}$)	850	mJ

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	•					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250 μA, V _{GS} = 0	600			V
	Zero gate voltage	V _{DS} = Max rating			10	μA
I _{DSS}	Drain current ($V_{GS} = 0$)	V_{DS} = Max rating, T_{C} = 125 °C			100	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 30V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 22.5A		0.09	0.11	Ω

Table 4. On/off states

Table 5. Dynamic

	Bynanne					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max,} I_{D} =$ 22.5A		15		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0		3800 1250 80		pF pF pF
C _{oss eq.} ⁽²⁾	Equivalent output capacitance	$V_{GS} = 0V$, $V_{DS} = 0V$ to 480V		340		pF
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 test signal level = 20mV open drain		1.4		Ω
Qg	Total gate charge	V _{DD} = 400V, I _D = 45A,		96	134	nC
Q _{gs}	Gate-source charge	$V_{GS} = 10V$		31		nC
Q _{gd}	Gate-drain charge	Figure 14		43		nC

1. Pulsed: Pulse duration = $300 \ \mu s$, duty cycle 1.5 %.

2. $C_{oss\;eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

	e interning timee					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	$V_{DD} = 250V, I_D = 22.5A$ $R_G = 4.7\Omega V_{GS} = 10V$ Figure 13		30 20		ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time Fall time Cross-over time	$\label{eq:VDD} \begin{split} V_{DD} &= 400 \text{V}, \text{I}_D = 45 \text{A}, \\ \text{R}_{\text{G}} &= 4.7 \Omega, \ \text{V}_{\text{GS}} = 10 \text{V} \\ \hline \textit{Figure 13} \end{split}$		16 23 40		ns ns ns

Table 6.Switching times

Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current				45	А
I _{SDM}	Source-drain current (pulsed)				180	А
V _{SD} ⁽¹⁾	Forward on voltage	$I_{SD} = 45A, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 45A, di/dt = 100A/μs, V _{DD} = 100 V, T _j = 25°C <i>Figure 15</i>		508 10 40		ns μC Α
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 45A,$ di/dt = 100A/µs, $V_{DD} = 100 V, T_j = 150^{\circ}C$ <i>Figure 15</i>		650 14 43		ns μC Α

1. Pulsed: Pulse duration = $300 \ \mu s$, duty cycle 1.5 %.

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Electrical characteristics (curves) 2.1

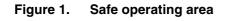
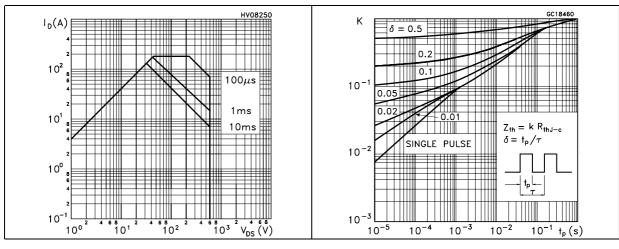
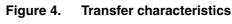
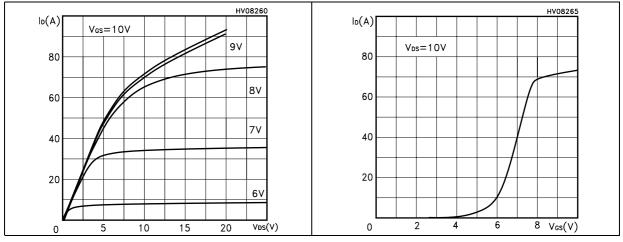


Figure 2. **Thermal impedance**

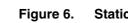




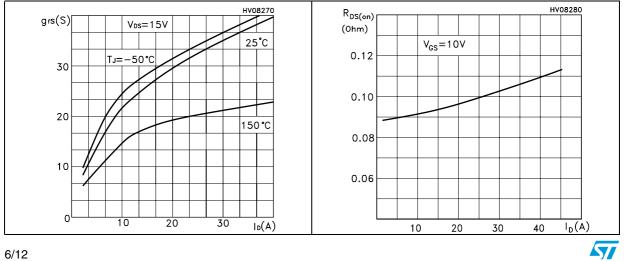


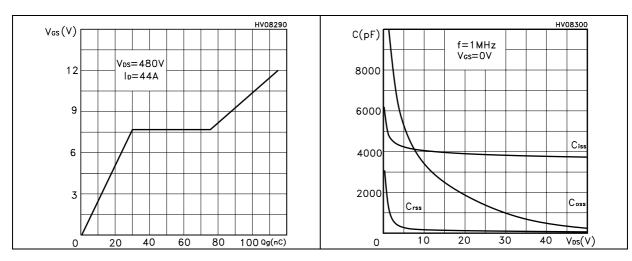






Static-drain source on resistance





Gate charge vs gate-source voltage Figure 8. Figure 7. **Capacitance variations**

Figure 9. vs temperature

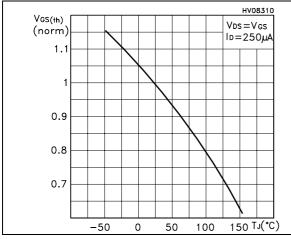
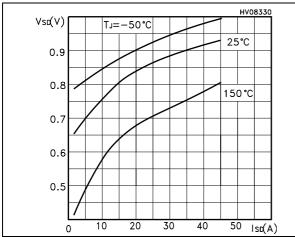


Figure 11. Source-drain diode forward characteristics



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Normalized gate threshold voltage Figure 10. Normalized on resistance vs temperature

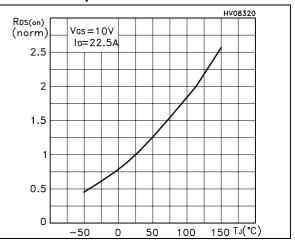
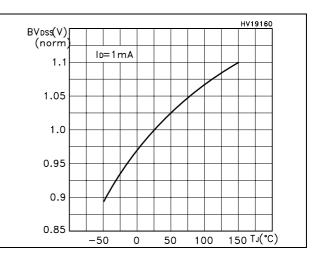
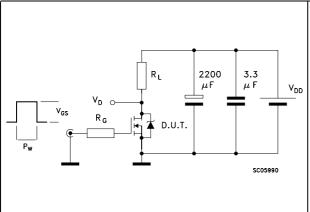


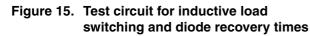
Figure 12. Normalized BV_{DSS} vs temperature

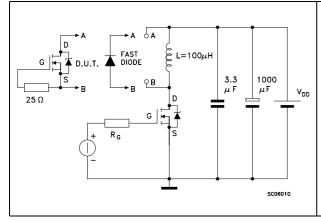


3 Test circuit

Figure 13. Switching times test circuit for resistive load









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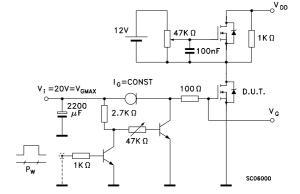
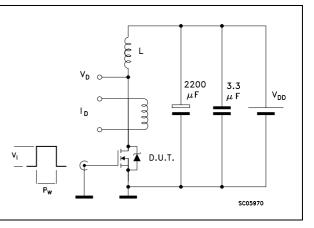
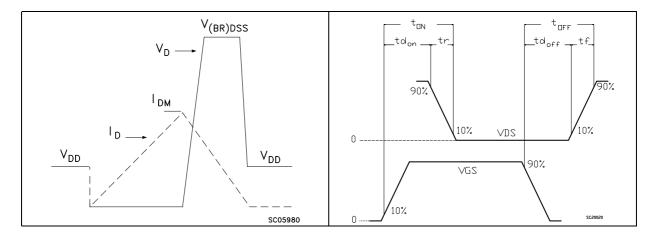


Figure 14. Gate charge test circuit

Figure 16. Unclamped inductive load test circuit









4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at : *www.st.com*





5 Revision history

Date	Revision	Changes
05-Mar-2005	5	Complete document with curves
16-May-2006	6	The document has been reformatted
18-Dec-2006	7	Updates curves: Figure 1., Figure 4. and Figure 6.



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